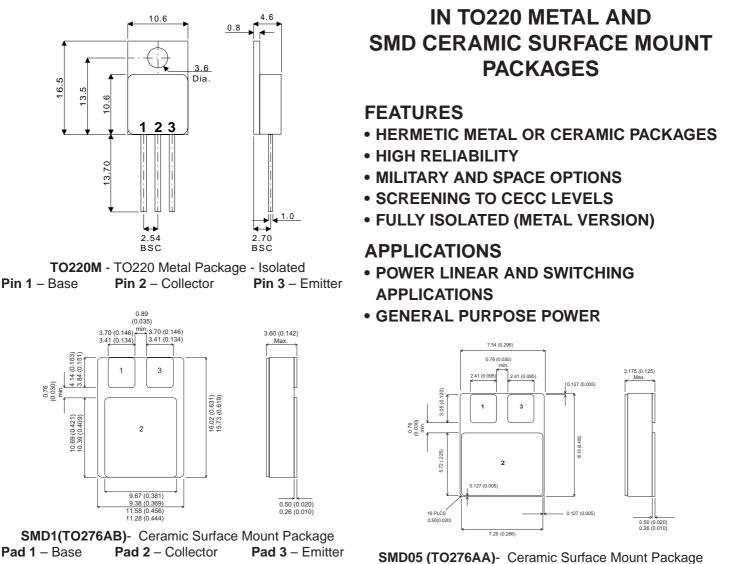


## BDS16 BDS16SMD BDS16SMD05 BDS17 BDS17SMD BDS17SMD05

SILICON NPN EPITAXIAL BASE

**MECHANICAL DATA** Dimensions in mm



Pad 1 – Base Pad 2 – Collector

Pad 3 – Emitter

ABSOLUT	<b>E MAXIMUM RATINGS</b> (T <sub>case</sub> =25°C unless otherwise stated)	BDS16	BDS17	
V <sub>CBO</sub>	Collector - Base voltage (I <sub>E</sub> = 0)	120V	150V	
V <sub>CEO</sub>	Collector - Emitter voltage (I <sub>B</sub> = 0)	120V 150V		
V <sub>EBO</sub>	Emitter - Base voltage (I <sub>C</sub> = 0)	5V		
I <sub>E</sub> , I <sub>C</sub>	Emitter, Collector current	8	A	
I <sub>B</sub>	Base current	2A		
P <sub>tot</sub>	Total power dissipation at $T_{case} \le 75^{\circ}C$	50W		
T <sub>stg</sub>	Storage Temperature	–65 TO 200°C		
Tj	Junction Temperature	200°C		

Semelab Plc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.



# BDS16BDS16SMDBDS16SMD05BDS17BDS17SMDBDS17SMD05

## **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25^{\circ}C$ unless otherwise stated)

	Parameter	Test Co	nditions	Min.	Тур.	Max.	Unit
I <sub>CBO</sub>	Collector cut-off current	BDS16	$V_{CB} = 120V$			20	μA
	$(I_{E} = 0)$	BDS17	$V_{CB} = 150V$			20	μΑ
I <sub>CEO</sub>	Collector cut-off current	BDS16	V <sub>CE</sub> = 60V			0.1 m	mA
	$(I_{B} = 0)$					0.1	
I <sub>EBO</sub>	Emitter cut-off current	BDS17	$V_{CE} = 75V$			10	
	$(I_{\rm C} = 0)$	$V_{EB} = 5V$				10	μΑ
V <sub>CEO(sus)*</sub>	Collector - Emitter	BDS16	I <sub>C</sub> = 100mA	120			V
	sustaining voltage ( $I_B = 0$ )	BDS17	$I_{\rm C} = 100 \text{mA}$	150			V
V	Collector - Emitter	I <sub>C</sub> = 4A	I <sub>B</sub> = 0.4A			1.5	V
V <sub>CE(sat)*</sub>	saturation voltage	I <sub>C</sub> = 0.5A	I <sub>B</sub> = 0.05A			0.4	V
V <sub>BE(on)*</sub>	Base - Emitter voltage	I <sub>C</sub> = 1A	$V_{CE} = 2V$			1.0	V
h <sub>FE*</sub>	DC Current gain	I <sub>C</sub> = 0.5A	$V_{CE} = 2V$	40		250	
		I <sub>C</sub> = 4A	$V_{CE} = 2V$	15		150	
f	Transition frequency	I <sub>C</sub> = 0.5A	$V_{CE} = 10V$	30			MHz
t <sub>T</sub>		F = 20MHz		30			

\*Pulsed : Pulse duration = 300  $\mu s$  , duty cycle = 1.5%

### SWITCHING CHARACTERISTICS

	Parameter		Test Conditions	Max.	Unit
t <sub>on</sub>	On Time	$(t_d + t_r)$	$I_{\rm C} = 2A$ $V_{\rm CC} = 80V$ $I_{\rm B1} = 0.2A$	0.5	μs
t <sub>s</sub>	Storage Time		$I_{\rm C} = 2$ A $V_{\rm CC} = 80$ V	1.5	μs
t <sub>f</sub>	Fall Time		$I_{B1} = -I_{B2} = 0.2A$	0.3	μs

### THERMAL DATA

R <sub>THj-case</sub>	Thermal resistance junction - case	Max. 2.5°C/W
R <sub>THj-a</sub>	Thermal resistance junction - ambient(TO-220 only)	Max. 62.5°C/W

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